

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideomi Suzawa et al. Art Unit : 2812
Serial No. : 09/852,672 Examiner : Alexander G. Ghyka
Filed : May 11, 2001 Confirmation No.: 5083
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SECOND REQUEST FOR INITIALED PTO FORM 1449

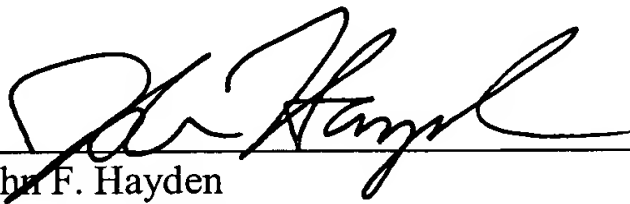
Further to a request filed November 5, 2004 and upon reviewing the file, applicants note that they have not yet received an initialed copy of the enclosed PTO Forms 1449 that accompanied the information disclosure statements filed June 12, 2002 and September 24, 2004.

On the PTO Form 1449 filed with the information disclosure statement dated June 12, 2002, please note that Desig. IDs AL through AN were initialed on another PTO Form 1449 filed with the supplemental information disclosure statement dated July 11, 2002. Therefore, the Examiner only needs to initial Desig. ID AA on the PTO Form 1449 filed with the information disclosure statement dated June 12, 2002.

Applicants' records show that these information disclosure statements complied with 37 CFR 1.97. Thus, it is respectfully requested that the Examiner initial and return these forms as soon as possible. Since applicants are paying the issue fee concurrently with this request, the Examiner's prompt attention to this matter would be appreciated.

Respectfully submitted,

Date: December 30, 2004



John F. Hayden
Reg. No. 37,640

Substitute Form PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
12732-038001Application No.
09/852,672**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant
Hideomi Suzawa et al.Filing Date
May 11, 2001Group Art Unit
2812**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,596,571	07/22/2003	ARAO et al.			06/05/2001
	AB	6,773,996	08/10/2004	SUZAWA et al.			05/10/2001
	AC	2001/0035526	11/01/2001	YAMAZAKI et al.			04/24/2001
	AD	2002/0110941	08/15/2002	YAMAZAKI et al.			01/26/2001
	AE	2002/0113552	08/22/2002	JUESTEL et al.			12/06/2001
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.